

# Search Notes



Application/Control No.

10/825,845

Examiner

Sara W. Crane

Applicant(s)/Patent under Reexamination

KOYAMA, EIJI

Art Unit

2811

## SEARCHED

Class	Subclass	Date	Examiner
257	291	10/05	SWC
	292		
	461		
	462		
	465		
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## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
as above		10/05	SWC

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR